

Notice of References Cited	Application/Control No. 09/656,315	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
	Examiner Christian La Forgia	Art Unit 2131	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,987,134	11-1999	Shin et al.	713/159
	B	US-5,144,556	09-1992	Wang et al.	707/9
	C	US-5,297,278	03-1994	Wang et al.	707/200
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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